Application/Control No.	Applicant(s)/Patent under Reexamination
10/044,287	CHALON, DENIS
Examiner	Art Unit

2155

Liang-che Alex Wang

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Class	Subclass	Date	Examiner
709	206	5/17/2005	LW
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Consulted with Patrice Winder	5/17/2005	LW
Backed search	5/17/2005	LW
Updated EAST Search: USPAT, EPO, JPO, DERWENT, IBMTDB	5/17/2005	LW
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